## Applicant(s)/Patent Under Application/Control No. Reexamination 09/809,074 NAGAMATSU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Quyen P. Leung 2828 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY 01-2001 Masuda et al 359/337.12 US-6172803 B1 Α В US-С US-D US-Ε US-US-F G US-US-Н ۱ US-US-US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO 9836479 A1 08-1998 WO Masuda et al 359/337.12 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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